Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination STEED ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,547,379 B2	04-2003	Chan et al.	347/92
	В	US-6,799,837 B1	10-2004	Chen et al.	347/56
	С	US-6,520,633 B2	02-2003	Nakamura, Hirotake	347/93
	D	US-4,929,963	05-1990	Balazar, Leonard	347/89
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р			·		
	Q				·	
	R					
	S					•
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	J	
	>	
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.